

One Cell Lithium-ion/Polymer Battery Protection IC

GENERAL DESCRIPTION

The XB5606AJ product is a high integration solution for lithiumion/polymer battery protection. XB5606AJ contains advanced power MOSFET, high-accuracy voltage detection circuits and delay circuits. XB5606AJ is put into an ultra-small SOT23-5 package and only one external component makes it an ideal solution in limited space of battery pack. XB5606AJ has all the protection functions required in the battery application including overcharging, overdischarging, overcurrent and load short circuiting protection etc. The accurate overcharging detection voltage ensures safe and full utilization charging. The low standby current drains little current from the cell while in storage.

The device is not only targeted for digital cellular phones, but also for any other Li-Ion and Li-Poly battery-powered information appliances requiring long-term battery life.

FEATURES

– Protection of Charger Reverse Connection

– Protection of Battery Cell Reverse Connection

– Integrate Advanced Power MOSFET with Equivalent of 17.5m Ω $R_{SS(ON)}$

- Ultra-small SOT23-5 Package

– Only One External Capacitor Required

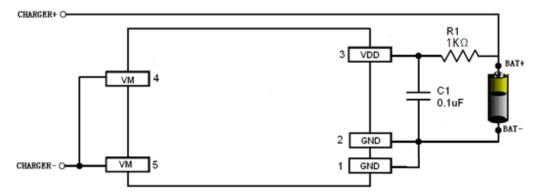
- Over-temperature Protection

Overcharge Current Protection

- Two-step Overcurrent Detection:
 Overdischarge Current
 Load Short Circuiting
- Charger Detection Function
- 0V Battery Charging Function
- Delay Times are generated inside
- High-accuracy Voltage Detection
- Low Current Consumption
 - Operation Mode: 3.5µ A typ.
 - Power-down Mode: 1.6µ A typ.
 - RoHS Compliant and Lead (Pb) Free

APPLICATIONS

One-Cell Lithium-ion Battery Pack Lithium-Polymer Battery Pack Power Bank





- 1 -



ORDERING INFORMATION

PART NUMBER	Pack age	Overcharg e Detection Voltage [Vcu] (V)	Overcharge Release Voltage [Vc∟] (V)	Overdischarge Detection Voltage [VDL] (V)	Overdischarge Release Voltage [VDR] (V)	Overcurrent Detection Current [Iov1] (A)	Top Mark
XB5606 AJ	SOT 23-5	4.30	4.10	2.40	3.0	9	5606AJYW(note)

Note: "YW" is manufacture date code, "Y" means the year, "W" means the week

PIN CONFIGURATION

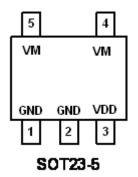


Figure 2. PIN Configuration

PIN DESCRIPTION

XB5606AJ PIN NUMBER	PIN NAME	PIN DESCRIPTION
1,2	GND	Ground, connect the negative terminal of the battery to this pin
3	VDD	Power Supply
4,5	VM	The negative terminal of the battery pack. The internal FET switch connects this terminal to GND

ABSOLUTE MAXIMUM RATINGS

(Note: Do not exceed these limits to prevent damage to the device. Exposure to absolute maximum rating conditions for long periods may affect device reliability.)

PARAMETER	VALUE	UNIT
VDD input pin voltage	-0.3 to 6	V
VM input pin voltage	-6 to 10	V
Operating Ambient Temperature	-40 to 85	°C
Maximum Junction Temperature	125	°C
Storage Temperature	-55 to 150	°C



Lead Temperature (Soldering, 10 sec)	300	°C
Power Dissipation at T=25°C	0.4	W
Package Thermal Resistance (Junction to Ambient) 0JA	250	°C/W
Package Thermal Resistance (Junction to Case) θια	130	°C/W
HBM ESD	2000	V

ELECTRICAL CHARACTERISTICS

Typicals and limits appearing in normal type apply for $T_A = 25^{O}C$, unless otherwise specified

Detection Voltage V _{CU} 4.25 4.30 4.35 V Overcharge Detection Voltage V _{CL} 4.05 4.10 4.15 V Overdischarge Detection Voltage V _{CL} 2.3 2.4 2.5 V Overdischarge Detection Voltage V _{DL} 2.9 3.0 3.1 V Overdischarge Release Voltage V _{DR} 2.9 3.0 3.1 V Overdischarge Release Voltage V _{DR} 2.9 3.0 3.1 V Overdischarge Current1 Detection *I _{IOV1} V _{DD} =3.6V 9 A Load Short-Circuiting Detection *I _{IOV1} V _{DD} =3.6V 9 A Current Consumption *I _{OVE} V _{DD} =3.6V 3.5 6 µ A Current Consumption in Normal Detection I _{OPE} V _{DD} =2.0V 3.5 6 µ A Current Consumption in power I _{PDN} V _{DD} =2.0V 300 kΩ µ A Minternal Resistance *R _{VMD} VDD=2.0V 300 kΩ	Parameter	Symbol	Test Condition	Min	Тур	Мах	Unit
Overcharge Detection Voltage V_{CU} Internal Network Note	Detection Voltage						
Overcharge Release Voltage V_{CL} Internal Resistance V Overdischarge Release Voltage V_{DL} 2.3 2.4 2.5 V Overdischarge Release Voltage V_{DR} 2.9 3.0 3.1 V Overdischarge Release Voltage V_{DR} 2.9 3.0 3.1 V Detection Current V V_{DD} V_{DD} 9 A Load Short-Circuiting $*I_{ISHORT}$ V_{DD} =3.6V 9 A Detection *I_SHORT V_{DD} =3.6V 45 A Current Consumption I V_{DP} =3.6V 3.5 6 μ A Current Consumption in Normal IOPE V_{DD} =2.0V 1.6 4 μ A Down IPDN VDD=2.0V 300 k\Omega K\Omega Internal Resistance between *R_VMD VDD=2.0V 300 kΩ Internal Resistance between VM *R_VMD VDD=3.6V 25 kΩ FET on Resistance *R_ND VDD=3.6V 17.5 mΩ Over Temperature Protection *T_SHO+	Overcharge Detection Voltage	V _{CU}		4.25	4.30	4.35	V
Overdischarge Detection Voltage VDL Image: Constraint of the second secon	Overcharge Release Voltage	V _{CL}		4.05	4.10	4.15	V
Overdischarge Release Voltage V_{DR} V_{DR} V_{DR} V_{DR} Detection Current V_{DR} V_{DD} 9 A Overdischarge Current1 Detection $*I_{IOV1}$ V_{DD} =3.6V 9 A Load Short-Circuiting $*I_{SHORT}$ V_{DD} =3.6V 45 A Detection $*I_{SHORT}$ V_{DD} =3.6V 45 A Current Consumption $Normal$ I_{OPE} V_{DD} =3.6V 3.5 6 μ A Current Consumption in power I_{PDN} V_{DD} =2.0V 1.6 4 μ A Down V_{DD} V_{DD} =2.0V 1.6 4 μ A VM Internal Resistance V_{VMD} V_{DD} =3.6V 25 $\kappa \Omega$ Internal Resistance between VM and V_{DD} $*R_{VMD}$ V_{DD} =3.6V 25 $\kappa \Omega$ FET on Resistance $*R_{SS(ON)}$ V_{DD} =3.6V V_{M} =1.0A 17.5 $m\Omega$ Over Temperature Protection $*T_{SHD+}$ I_{50} $\circ \infty$ ∞	Overdischarge Detection Voltage	V _{DL}		2.3	2.4	2.5	V
Overdischarge Current1Detection*I*IVDD=3.6V9ALoad Short-Circuiting Detection*ISHORT $V_{DD}=3.6V$ 45ACurrent ConsumptionNormal OperationIOPE VDD=2.0V VM endVDD=3.6V3.56 μ ACurrent Consumption in Normal OperationIOPE VDD=2.0V 	Overdischarge Release Voltage	V _{DR}		2.9	3.0	3.1	V
Load Short-Circuiting Detection*I_SHORT $V_{DD}=3.6V$ 45ACurrent ConsumptionI Operation $V_{DD}=3.6V$ 45ACurrent Consumption in Normal OperationI Ope $V_{DD}=3.6V$ 3.56 μ ACurrent Consumption in power DownI IPDN $V_{DD}=2.0V$ 1.64 μ ACurrent Consumption in power DownI IPDN $V_{DD}=2.0V$ VM pin floating1.64 μ AVM Internal Resistance*R_VMDVDD=2.0V VM pin floating300k Ω Internal Resistance between M and V_DD*R_VMSVDD=3.6V VM=1.0V25k Ω FET on Resistance*R_S(ON) $V_{DD}=3.6V$ VD=3.6V VD=3.6V17.5m Ω Over Temperature Protection*T_SHD+150°C	Detection Current						
DetectionSNORTTUD STORTTUD STORTTUD STORTCurrent ConsumptionNormal I_{OPE} $V_{DD}=3.6V$ VM =0V 3.5 6 μ ACurrent Consumption in power Down I_{PDN} $V_{DD}=2.0V$ VM pin floating 1.6 4 μ AVM Internal ResistanceInternal Resistance between VM and V_{DD} $*R_{VMD}$ $VDD=2.0V$ VM pin floating 300 $k\Omega$ Internal Resistance between VM and V_{DD} $*R_{VMD}$ $VDD=2.0V$ VM pin floating 300 $k\Omega$ Internal Resistance between VM and GND $*R_{VMS}$ $V_{DD}=3.6V$ VM=1.0V 25 $k\Omega$ FET on ResistanceEquivalent FET on Resistance $*R_{SS(ON)}$ $V_{DD}=3.6V$ VDD= $3.6V$ 17.5 $m\Omega$ Over Temperature ProtectionOver Temperature Protection $*T_{SHD+}$ 150 \circ_C	Overdischarge Current1 Detection	*I _{IOV1}	V _{DD} =3.6V		9		A
Current Consumption in Normal Operation I_{OPE} $V_{DD}=3.6V$ $VM = 0V$ 3.5 6 μ ACurrent Consumption in power Down I_{PDN} $V_{DD}=2.0V$ $VM pin floating1.64\mu AVMInternal ResistanceInternal Resistance betweenVM and V_{DD}*R_{VMD}VDD=2.0VVM pin floating300\kappa\OmegaInternal Resistance betweenVM and V_{DD}*R_{VMD}VDD=2.0VVM pin floating300\kappa\OmegaInternal Resistance between VMand GND*R_{VMS}V_{DD}=3.6VVM=1.0V25\kappa\OmegaFET on ResistanceEquivalent FET on Resistance*R_{SS}(ON)V_{DD}=3.6VV_{DD}=3.6V17.5m\OmegaOver Temperature ProtectionOver Temperature Protection*T_{SHD+}150\circ^{\circ}C$	5	*I _{SHORT}	V _{DD} =3.6V		45		A
OperationVM =0VP MCurrent Consumption in power Down I_{PDN} $V_{DD}=2.0V$ VM pin floating1.64 μ AVM Internal ResistanceInternal Resistance between VM and V_{DD} $^*R_{VMD}$ $VDD=2.0V$ VM pin floating300 $k\Omega$ Internal Resistance between VM and V_{DD} $^*R_{VMS}$ $V_{DD}=3.6V$ VM pin floating25 $k\Omega$ Internal Resistance between VM and GND $^*R_{VMS}$ $V_{DD}=3.6V$ VM=1.0V25 $k\Omega$ FET on ResistanceEquivalent FET on Resistance $^*R_{SS(ON)}$ $V_{DD}=3.6V$ VDD=3.6V17.5 $m\Omega$ Over Temperature ProtectionOver Temperature Protection $^*T_{SHD+}$ 150 $^{\circ}C$	Current Consumption						
Down VM pin floating P M VM Internal Resistance VM pin floating 300 kΩ Internal Resistance between *R _{VMD} VDD=2.0V VM pin floating 300 kΩ Internal Resistance between VM and GND *R _{VMS} VDD=3.6V VM=1.0V 25 kΩ FET on Resistance *R _{SS(ON)} VDD=3.6V VM=1.0V 17.5 mΩ Over Temperature Protection *T _{SHD+} 150 °C		I _{OPE}			3.5	6	μA
Internal Resistance between VM and VDD*R_VMDVDD=2.0V VM pin floating300kΩInternal Resistance between VM and GND*R_VMSVDD=3.6V VM=1.0V25kΩFET on ResistanceEquivalent FET on Resistance*R_SS(ON)VDD=3.6V VDD=3.6V17.5mΩOver Temperature Protection*T_SHD+150°C	• •	I _{PDN}	55		1.6	4	μA
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	VM Internal Resistance						
and GND VM=1.0V kΩ FET on Resistance *R _{SS(ON)} V _{DD} =3.6V I _{VM} =1.0A 17.5 mΩ Over Temperature Protection *T _{SHD+} 150 °C		*R _{VMD}	-		300		kΩ
Equivalent FET on Resistance *R _{SS(ON)} V _{DD} =3.6V IVM =1.0A 17.5 mΩ Over Temperature Protection *T _{SHD+} 150 o°C		*R _{VMS}			25		kΩ
Over Temperature Protection *T _{SHD+} 150 °C	FET on Resistance				•	•	•
Over Temperature Protection *T _{SHD+} 150 °C	Equivalent FET on Resistance	*R _{SS(ON)}	V _{DD} =3.6V I _{VM} =1.0A		17.5		mΩ
	Over Temperature Protection						
Over Temperature Recovery Degree *T _{SHD} .	Over Temperature Protection	*T _{SHD+}			150		00
	Over Temperature Recovery Degree	*T _{SHD-}			110		

www.xysemi.com



Detection Delay Time					
Overcharge Voltage Detection Delay Time	t _{CU}		130	200	mS
Overdischarge Voltage Detection Delay Time	t _{DL}		40	60	mS
Overdischarge Current Detection Delay Time	*t _{IOV}	V _{DD} =3.6V	8		mS
Load Short-Circuiting Detection Delay Time	*t _{SHOR} T	V _{DD} =3.6V	360		uS

Note: * ---The parameter is guaranteed by design.

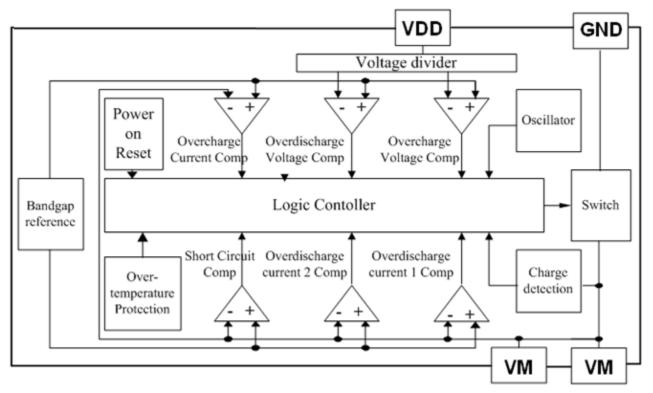


Figure 3. Functional Block Diagram

FUNCTIONAL DESCRIPTION

The XB5606AJ monitors the voltage and current of a battery and protects it from being damaged due to overcharge voltage, overdischarge voltage, overdischarge current, and short circuit conditions by disconnecting the battery from the load or charger. These functions are required in order to operate the battery cell within specified limits.

The device requires only one external capacitor. The MOSFET is integrated and its $R_{SS(ON)}$ is as low as 17.5m Ω typical.

Normal operating mode

If no exception condition is detected, charging and discharging can be carried out freely. This condition is called the normal operating mode.

Overcharge Condition

When the battery voltage becomes higher than the overcharge detection voltage (Vcu) during charging under normal condition and the state continues for the overcharge detection delay time (tcu) or longer, the



XB5606AJ turns the charging control FET off to stop charging. This condition is called the overcharge condition. The overcharge condition is released in the following two cases:

1, When the battery voltage drops below the overcharge release voltage (VcL), the XB5606AJ turns the charging control FET on and returns to the normal condition. 2. When a load is connected and discharging starts, the XB5606AJ turns the charging control FET on and returns to the normal condition. The release mechanism is as follows: the discharging current flows through an internal parasitic diode of the charging FET immediately after a load is connected and discharging starts, and the VM pin voltage increases about 0.7 V (forward voltage of the diode) from the GND pin voltage momentarily. The XB5606AJ detects this voltage and releases the overcharge condition. Consequently, in the case that the battery voltage is equal to or lower than the overcharge detection voltage (Vcu), the XB5606AJ returns to the normal condition immediately, but in the case the battery voltage is higher than the overcharge detection voltage (Vcu), the chip does not return to the normal condition until the battery voltage drops below the overcharge detection voltage (Vcu) even if the load is connected. In addition, if the VM pin voltage is equal to or lower than the overcurrent 1 detection voltage when a load is connected and discharging starts, the chip does not return to the normal condition.

Remark If the battery is charged to a voltage higher than the overcharge detection voltage (VcU) and the battery voltage does not drops below the overcharge detection voltage (VCU) even when a heavy load, which causes an overcurrent, is connected, the overcurrent 1 and overcurrent 2 do not work until the battery voltage drops below the overcharge detection voltage (VCU). Since an actual battery has, however, an internal impedance of several dozens of $m\Omega$, and the battery voltage drops immediately after a heavy load which causes an overcurrent is connected, the overcurrent 1 and overcurrent 2 work. Detection of load shortcircuiting works regardless of the battery voltage.

Overdischarge Condition

When the battery voltage drops below the overdischarge detection voltage (V_{DL}) during discharging under normal condition and it continues for the overdischarge detection delay time (t_{DL}) or longer, the XB5606AJ turns the discharging control FET off and stops discharging. This condition is called overdischarge condition. After the discharging control FET is turned off, the VM pin is pulled up by the R_{VMD} resistor

between VM and VDD in XB5606AJ. Meanwhile when VM is bigger than 1.5 V (typ.) (the load short-circuiting detection voltage), the current of the chip is reduced to the power-down current (IPDN). This condition is called power-down condition. The VM and VDD pins are shorted by the RVMD resistor in the IC under the overdischarge and power-down conditions. The power-down condition is released when a charger is connected and the potential difference between VM and VDD becomes 1.3 V (typ.) or higher (load shortcircuiting detection voltage). At this time, the FET is still off. When the battery voltage becomes the overdischarge detection voltage (V_{DL}) or higher (see note), the XB5606AJ turns the FET on and changes to the normal condition from the overdischarge condition.

Remark If the VM pin voltage is no less than the charger detection voltage (VCHA), when the battery under overdischarge condition is connected to a charger, the overdischarge condition is released (the discharging control FET is turned on) as usual, provided that the battery voltage reaches the overdischarge release voltage (VDU) or higher.

Overcurrent Condition



When the discharging current becomes equal to or higher than a specified value (the VM pin voltage is equal to or higher than the overcurrent detection voltage) during discharging under normal condition and the state continues for the overcurrent detection delay time or longer, the XB5606AJ turns off the discharging control FET to stop discharging. This condition is called overcurrent condition. (The overcurrent

includes overcurrent, or load shortcircuiting.)

The VM and GND pins are shorted internally by the R_{VMS} resistor under the overcurrent condition. When a load is connected, the VM pin voltage equals the VDD voltage due to the load.

The overcurrent condition returns to the normal condition when the load is released and the impedance between the B+ and B-pins becomes higher than the automatic recoverable impedance. When the load is removed, the VM pin goes back to the GND potential since the VM pin is shorted the GND pin with the R_{VMS} resistor. Detecting that the VM pin potential is lower than the overcurrent detection voltage (V_{IOV}), the IC returns to the normal condition.

Abnormal Charge Current Detection

If the VM pin voltage drops below the charger detection voltage (V_{CHA}) during charging under the normal condition and it continues for the overcharge detection delay time (t_{CU}) or longer, the XB5606AJ turns the charging control FET off and stops charging. This action is called abnormal charge current detection. Abnormal charge current detection works when the discharging control FET is on and the VM pin voltage drops below the charger detection voltage (V_{CHA}). When an abnormal charge current flows into a battery in the overdischarge condition, the

XB5606AJ consequently turns the charging control FET off and stops charging after the battery voltage becomes the overdischarge detection voltage and the overcharge detection delay time (tcu) elapses.

Abnormal charge current detection is released when the voltage difference between VM pin and GND pin becomes lower than the charger detection voltage (VCHA) by separating the charger. Since the 0 V battery charging function has higher priority than the abnormal charge current detection function, abnormal charge current may not be detected by the product with the 0 V battery charging function while the battery voltage is low.

Load Short-circuiting condition

If voltage of VM pin is equal or below short circuiting protection voltage (V_{SHORT}), the XB5606AJ will stop discharging and battery is disconnected from load. The maximum delay time to switch current off is t_{SHORT}. This status is released when voltage of VM pin is higher than short protection voltage (V_{SHORT}), such as when disconnecting the load.

Delay Circuits

The detection delay time for overdischarge current 2 and load short-circuiting starts when overdischarge current 1 is detected. As soon as overdischarge current 2 or load short-circuiting is detected over detection delay time for overdischarge current 2 or load short- circuiting, the XB5606AJ stops discharging. When battery voltage falls below overdischarge detection voltage due to overdischarge current, the XB5606AJ stop discharging by overdischarge current detection. In this case the recovery of battery voltage is so slow that if battery voltage after overdischarge voltage detection delay

XySemi Inc



XB5606AJ

time is still lower than overdischarge detection voltage, the XB5606AJ shifts to power-down.

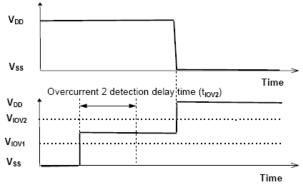


Figure 4. Overcurrent delay time

OV Battery Charging Function ^{(1) (2) (3)} This function enables the charging of a connected battery whose voltage is 0 V by self-discharge. When a charger having 0 V battery start charging charger voltage (V_{OCHA}) or higher is connected between B+ and B- pins, the charging control FET gate is fixed to VDD potential. When the voltage

between the gate and the source of the charging control FET becomes equal to or higher than the turn-on voltage by the charger voltage, the charging control FET is turned on to start charging. At this time, the discharging control FET is off and the charging current flows through the internal parasitic diode in the discharging control FET. If the battery voltage becomes equal to or higher than the overdischarge release voltage (V_{DU}), the normal condition returns.

Note

(1) Some battery providers do not recommend charging of completely discharged batteries. Please refer to battery providers before the selection of 0 V battery charging function.

(2) The 0V battery charging function has higher priority than the abnormal charge current detection function. Consequently, a product with the 0 V battery charging function charges a battery and abnormal charge current cannot be detected during the battery voltage is low (at most 1.8 V or lower).
(3) When a battery is connected to the IC for the first time, the IC may not enter the normal condition in which discharging is possible. In this case, set the VM pin voltage equal to the GND voltage (short the VM and GND pins or connect a charger) to enter the normal condition.



TIMING CHART

1. Overcharge and overdischarge detection

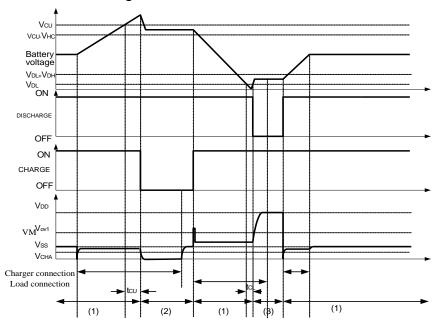


Figure 5-1 Overcharge and Overdischarge Voltage Detection

2. Overdischarge current detection

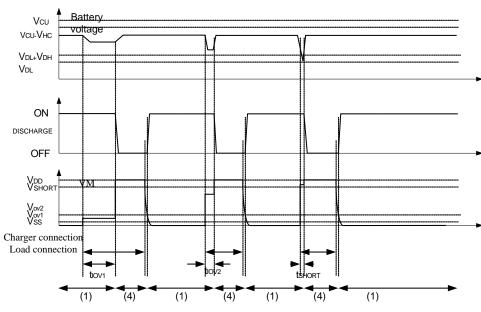


Figure 5-2 Overdischarge Current Detection

Remark: (1) Normal condition (2) Overcharge voltage condition (3) Overdischarge voltage condition (4) Overcurrent condition

XySemi Inc

www.xysemi.com



3. Charger Detection

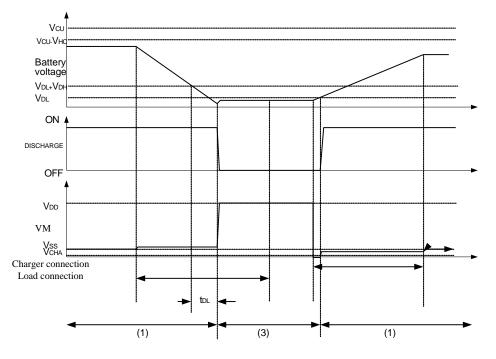
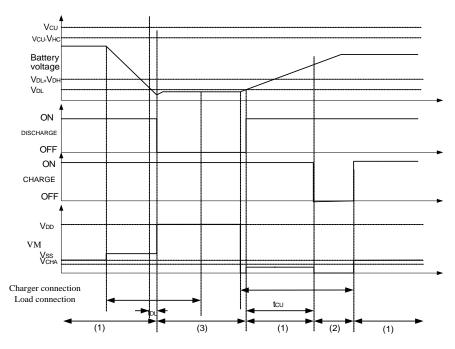


Figure5-3 Charger Detection

4. Abnormal Charger Detection





Remark: (1) Normal condition (2) Overcharge voltage condition (3) Overdischarge voltage condition (4) Overcurrent condition

XySemi Inc

www.xysemi.com



TYPICAL APPLICATION

As shown in Figure 6, the bold line is the high density current path which must be kept as short as possible. For thermal management, ensure that these trace widths are adequate.C1& R1 is a decoupling capacitor & resistor which should be placed as close as possible to XB5606AJ.

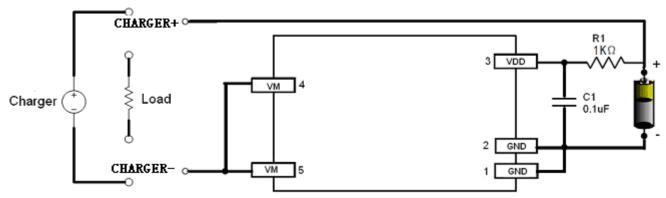


Fig 6 XB5606AJ in a Typical Battery Protection Circuit

Precautions

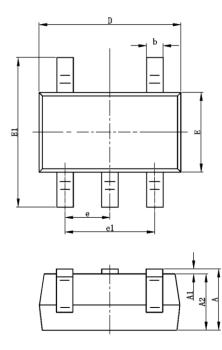
• Pay attention to the operating conditions for input/output voltage and load current so that the power loss in XB5606AJ does not exceed the power dissipation of the package.

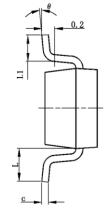
• Do not apply an electrostatic discharge to this XB5606AJ that exceeds the performance ratings of the built-in electrostatic protection circuit.



PACKAGE OUTLINE

SOT23-5 PACKAGE OUTLINE AND DIMENSIONS





SYMB OL	I	NSION N ETERS	DIMENSION IN INCHES		
	MIN	MAX	MIN	MAX	
А	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.400	0.012	0.016	
С	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
Е	1.500	1.700	0.059	0.067	
E1	2.650	2.950	0.104	0.116	
е	e 0.950 TYP		0.037 TYP		
e1	1.800	2.000	0.071	0.079	
L	0.700	REF	0.028 REF		
L1	0.300	0.600	0.012	0.024	
θ	0°	8°	0°	8°	



DISCLAIMER

The information described herein is subject to change without notice.

Xysemi Inc. is not responsible for any problems caused by circuits or diagrams described herein whose ralated industial properties,patents,or other rights belong to third parties. The application circuit examples explain typical applications of the products, and do not guarantee the success of any specific mass-production design.

When the products described herein are regulated products subject to the Wassenaar Arrangement or other arrangements, they may not be exported without authorization from the appropriate governmental authority.

Use of the information described herein for other purposes and/or reproduction or copying without express permission of Xysemi Inc. is strictly prohibited.

The products described herein cannot be used as part of any device or equipment affecting the human body, such as exercise equipment , medical equipment, security systems, gas equipment, or any aparatus installed in airplanes and other vehicles, without prior written pemission of Xysemi Inc.

Although Xysemi Inc. exerts the greatest possible effort to ensure high quality and reliability, the failure or malfunction of semiconductor may occur. The use of these products should therefore give thorough consideration to safty design,including redundancy, fire-prevention measure and malfunction prevention, to prevent any accidents,fires,or community damage that may ensue.